



**SEMITRANS® 5**

## IGBT4 Modules

### Engineering Sample SKM600GAE12E4

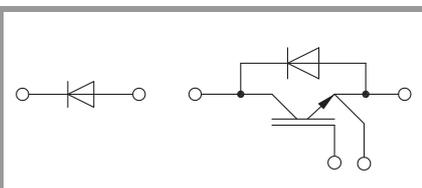
#### Target Data

#### Features

- IGBT4 = 4. generation medium fast trench IGBT
- CAL4F = Soft switching 4. generation CAL-diode
- Enhanced 900A free-wheeling diode
- With integrated gate resistor
- Isolated copper baseplate using DBC technology (Direct Bonded Copper)
- UL recognized, file no. E63532

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ$



**GAE**

Absolute Maximum Ratings					
Symbol	Conditions		Values	Unit	
<b>IGBT</b>					
$V_{CES}$	$T_j = 25^\circ\text{C}$		1200	V	
$I_C$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	913	A	
		$T_c = 80^\circ\text{C}$	702	A	
$I_{Cnom}$			600	A	
$I_{CRM}$	$I_{CRM} = 3 \times I_{Cnom}$		1800	A	
$V_{GES}$			-20 ... 20	V	
$t_{psc}$	$V_{CC} = 800\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_j = 150^\circ\text{C}$	10		$\mu\text{s}$
$T_j$			-40 ... 175	$^\circ\text{C}$	
<b>Inverse diode</b>					
$I_F$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	54	A	
		$T_c = 80^\circ\text{C}$	41	A	
$I_{Fnom}$			50	A	
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$		100	A	
$I_{FSM}$	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		180	A	
$T_j$			-40 ... 175	$^\circ\text{C}$	
<b>Freewheeling diode</b>					
$I_F$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	936	A	
		$T_c = 80^\circ\text{C}$	695	A	
$I_{Fnom}$			900	A	
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$		1800	A	
$I_{FSM}$	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		4320	A	
$T_j$			-40 ... 175	$^\circ\text{C}$	
<b>Module</b>					
$I_{t(RMS)}$			500	A	
$T_{stg}$			-40 ... 125	$^\circ\text{C}$	
$V_{isol}$	AC sinus 50 Hz, $t = 1\text{ min}$		2500	V	

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>IGBT</b>						
$V_{CE(sat)}$	$I_C = 600\text{ A}$ $V_{GE} = 15\text{ V}$ chipllevel	$T_j = 25^\circ\text{C}$	1.80	2.05		V
		$T_j = 150^\circ\text{C}$	2.20	2.42		V
$V_{CE0}$	chipllevel	$T_j = 25^\circ\text{C}$	0.80	0.90		V
		$T_j = 150^\circ\text{C}$	0.70	0.80		V
$r_{CE}$	$V_{GE} = 15\text{ V}$ chipllevel	$T_j = 25^\circ\text{C}$	1.67	1.92		$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	2.5	2.7		$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 24\text{ mA}$		5	5.8	6.5	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_j = 25^\circ\text{C}$			5	mA
		$T_j = 150^\circ\text{C}$			-	mA
$C_{ies}$	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$		37.2		nF
$C_{oes}$		$f = 1\text{ MHz}$		2.32		nF
$C_{res}$		$f = 1\text{ MHz}$		2.04		nF
$Q_G$	$V_{GE} = -8\text{ V} \dots +15\text{ V}$			3400		nC
$R_{Gint}$	$T_j = 25^\circ\text{C}$			1.3		$\Omega$



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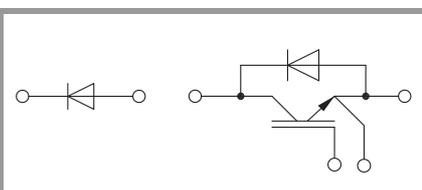
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- Product reliability results valid for  $T_j = 150^\circ$

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
$t_{d(on)}$	$V_{CC} = 600\text{ V}$	$T_j = 150^\circ\text{C}$		195		ns
$t_r$	$I_C = 600\text{ A}$	$T_j = 150^\circ\text{C}$		91		ns
$E_{on}$	$V_{GE} = +15/-15\text{ V}$	$T_j = 150^\circ\text{C}$		81		mJ
$t_{d(off)}$	$R_{G\ on} = 2\ \Omega$	$T_j = 150^\circ\text{C}$		695		ns
$t_f$	$R_{G\ off} = 2\ \Omega$	$T_j = 150^\circ\text{C}$		131		ns
$E_{off}$	$di/dt_{on} = 6000\text{ A}/\mu\text{s}$ $di/dt_{off} = 5200\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		83		mJ
$R_{th(j-c)}$	per IGBT				0.049	K/W
Inverse diode						
$V_F = V_{EC}$	$I_F = 50\text{ A}$	$T_j = 25^\circ\text{C}$		2.41	2.74	V
	$V_{GE} = 0\text{ V}$ chiplevel	$T_j = 150^\circ\text{C}$		2.45	2.79	V
$V_{F0}$	chiplevel	$T_j = 25^\circ\text{C}$		1.30	1.50	V
		$T_j = 150^\circ\text{C}$		0.90	1.10	V
$r_F$	chiplevel	$T_j = 25^\circ\text{C}$		22	25	m $\Omega$
		$T_j = 150^\circ\text{C}$		31	34	m $\Omega$
$I_{RRM}$	$I_F = 50\text{ A}$	$T_j = 150^\circ\text{C}$				A
$Q_{rr}$	$di/dt_{off} = 5500\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$				$\mu\text{C}$
$E_{rr}$	$V_{GE} = \pm 15\text{ V}$ $V_{CC} = 600\text{ V}$	$T_j = 150^\circ\text{C}$				mJ
$R_{th(j-c)}$	per diode				1	K/W
Freewheeling diode						
$V_F = V_{EC}$	$I_F = 900\text{ A}$	$T_j = 25^\circ\text{C}$		2.14	2.46	V
	$V_{GE} = 0\text{ V}$ chiplevel	$T_j = 150^\circ\text{C}$		2.07	2.38	V
$V_{F0}$	chiplevel	$T_j = 25^\circ\text{C}$		1.3	1.5	V
		$T_j = 150^\circ\text{C}$		0.9	1.1	V
$r_F$	chiplevel	$T_j = 25^\circ\text{C}$		0.93	1.07	m $\Omega$
		$T_j = 150^\circ\text{C}$		1.30	1.42	m $\Omega$
$I_{RRM}$	$I_F = 600\text{ A}$	$T_j = 150^\circ\text{C}$		384		A
$Q_{rr}$	$di/dt_{off} = 5500\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		83		$\mu\text{C}$
$E_{rr}$	$V_{GE} = \pm 15\text{ V}$ $V_{CC} = 600\text{ V}$	$T_j = 150^\circ\text{C}$		47		mJ
$R_{th(j-c)}$	per diode				0.07	K/W
Module						
$L_{CE}$				15		nH
$R_{CC+EE}$	measured per switch	$T_C = 25^\circ\text{C}$		0.18		m $\Omega$
		$T_C = 125^\circ\text{C}$		0.22		m $\Omega$
$R_{th(c-s)}$	calculated without thermal coupling			0.02	0.038	K/W
$M_s$	to heat sink M6			3	5	Nm
$M_t$	to terminals M6			2.5	5	Nm
						Nm
$w$					310	g



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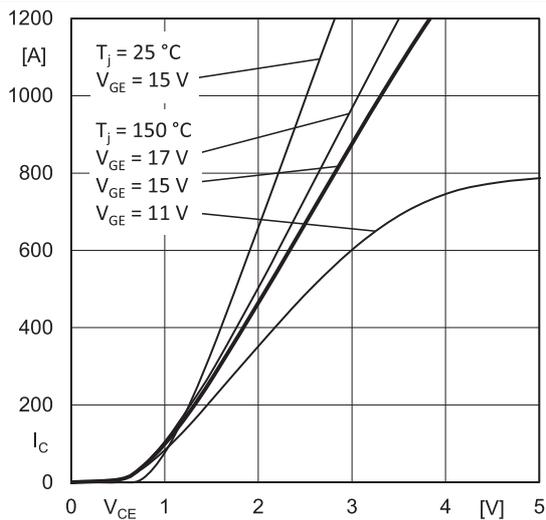


Fig. 1: Typ. output characteristic, inclusive  $R_{CC+EE'}$

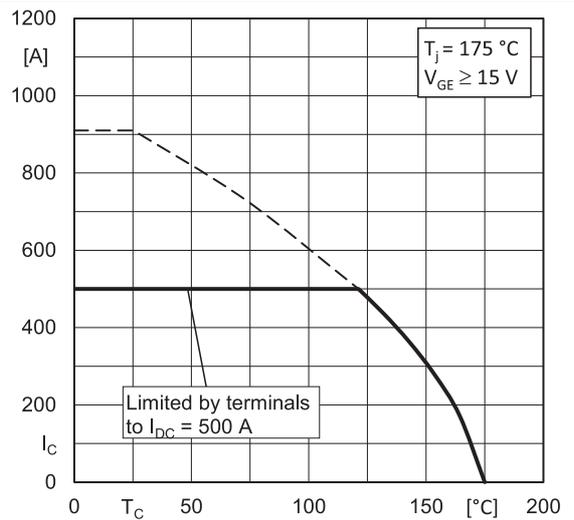


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

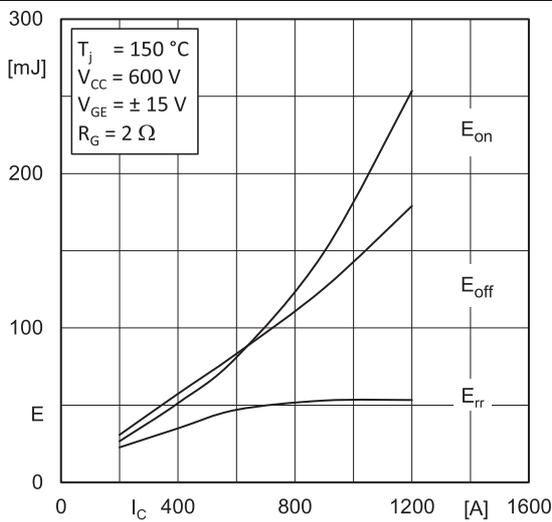


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

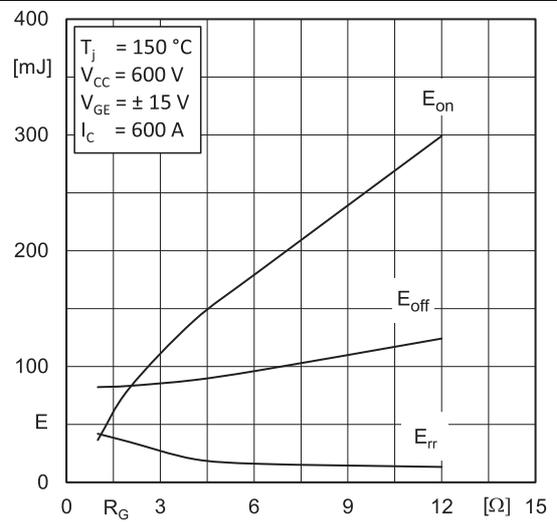


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

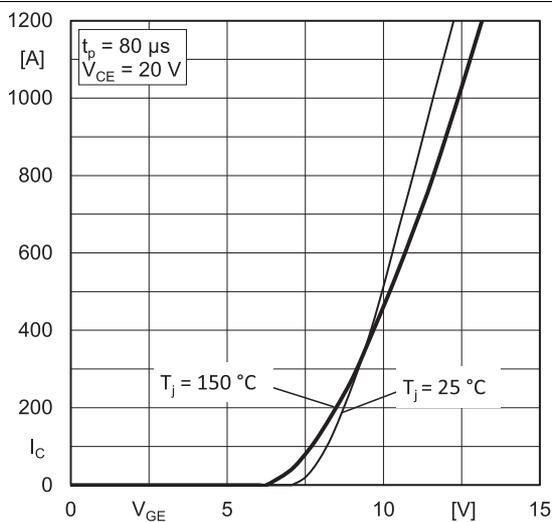


Fig. 5: Typ. transfer characteristic

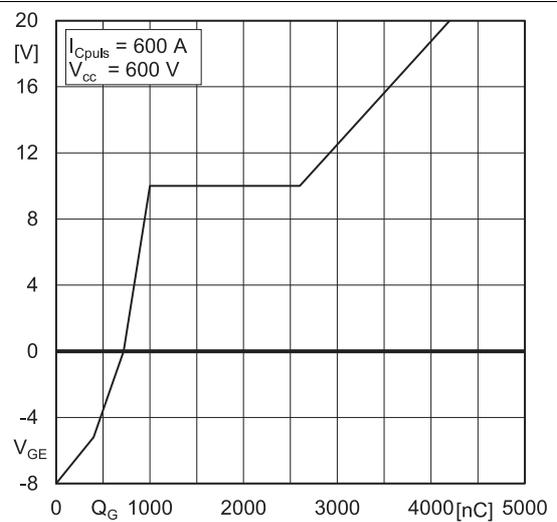


Fig. 6: Typ. gate charge characteristic

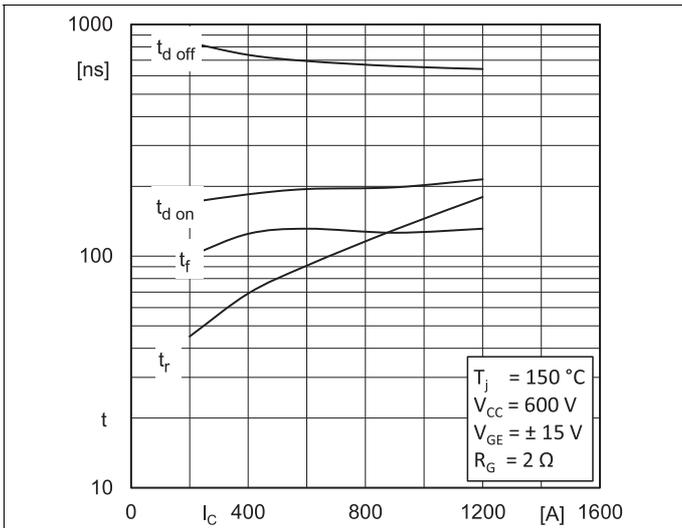


Fig. 7: Typ. switching times vs.  $I_C$

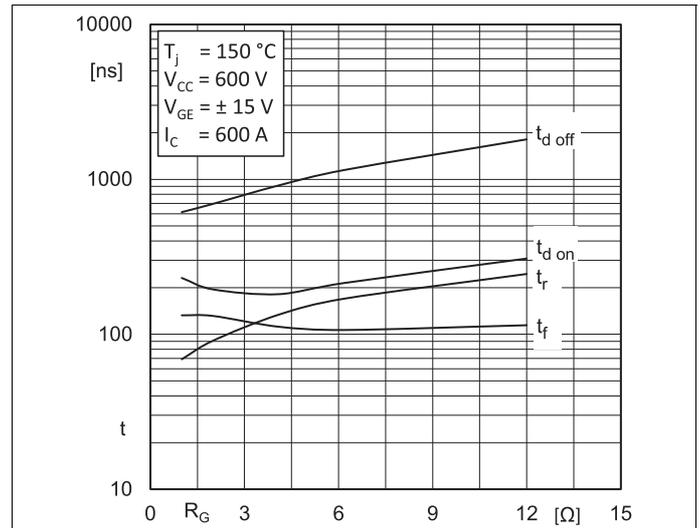


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

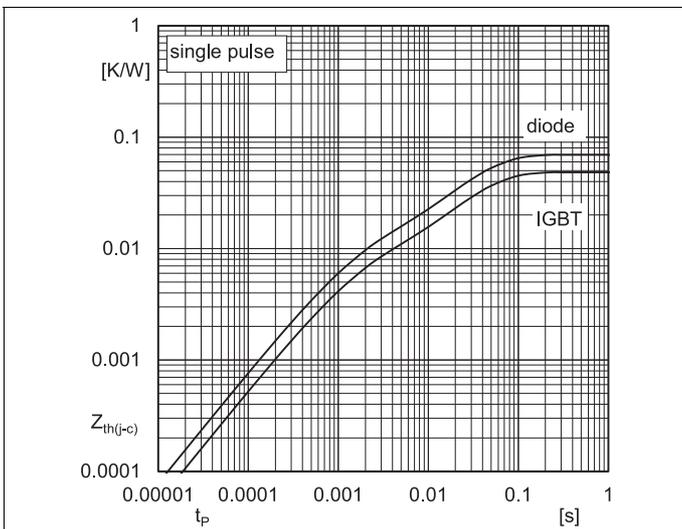


Fig. 9: Transient thermal impedance

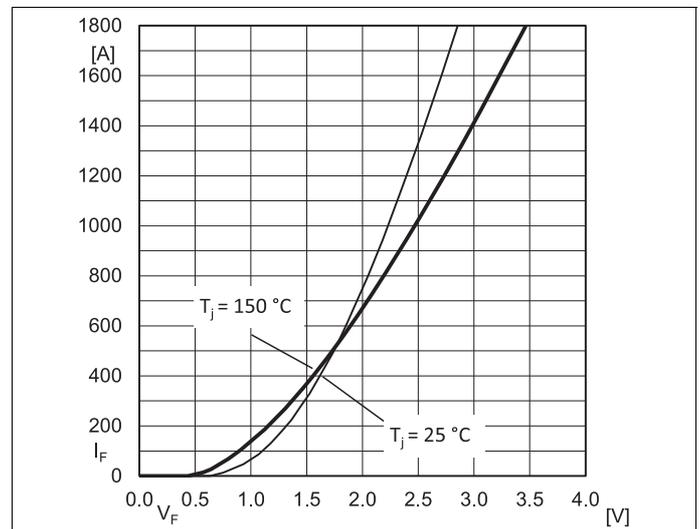


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC+EE'}$

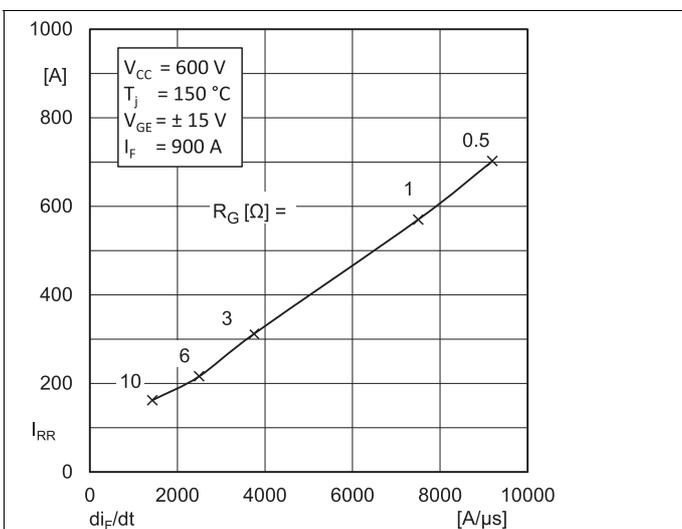


Fig. 11: CAL diode peak reverse recovery current

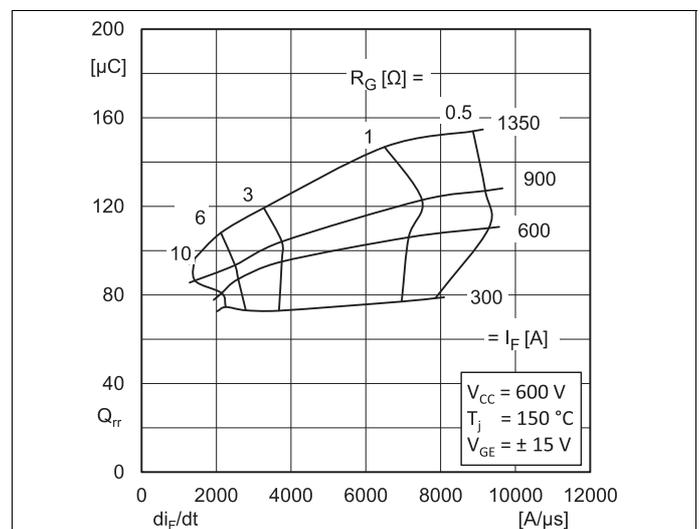
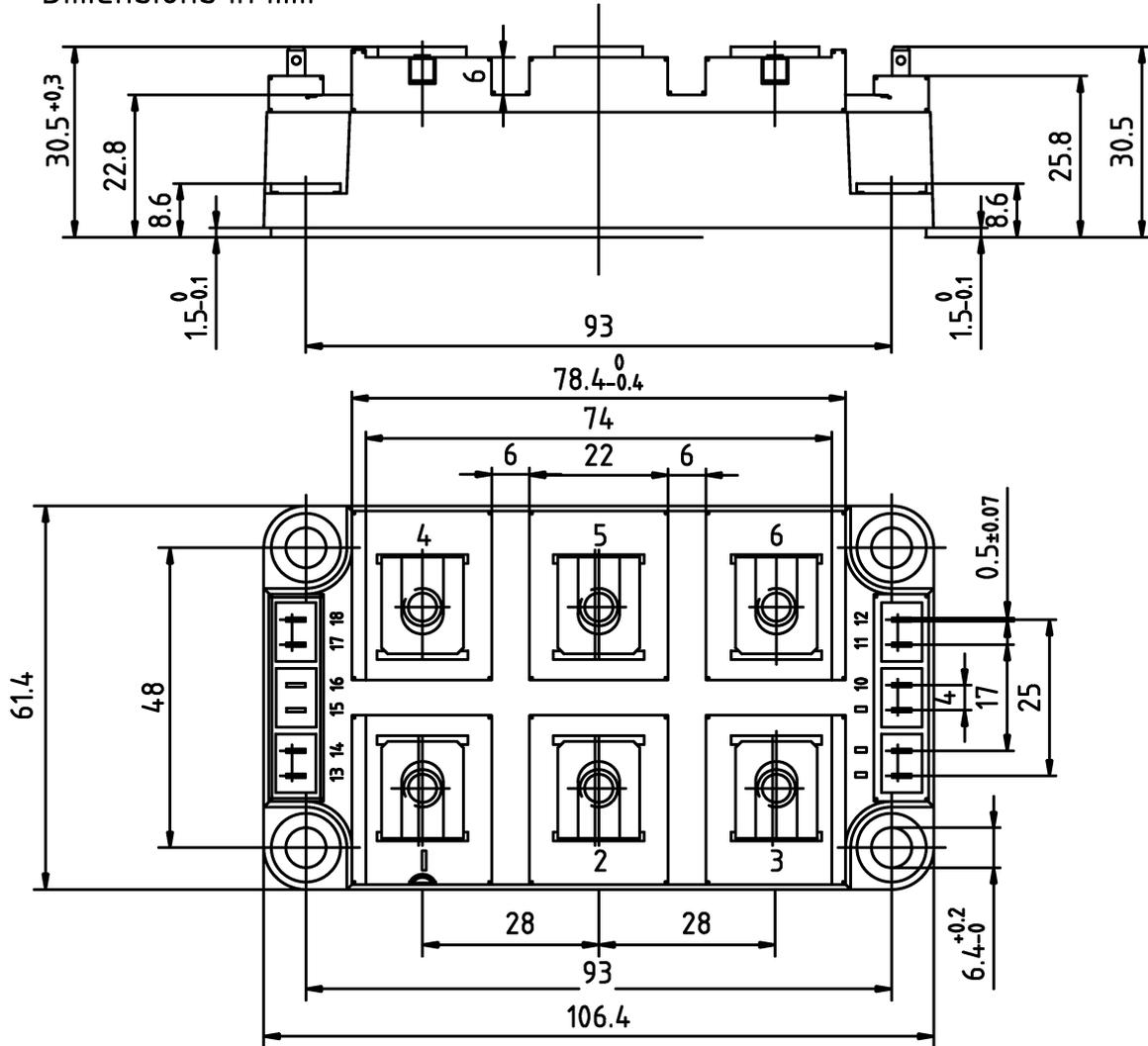
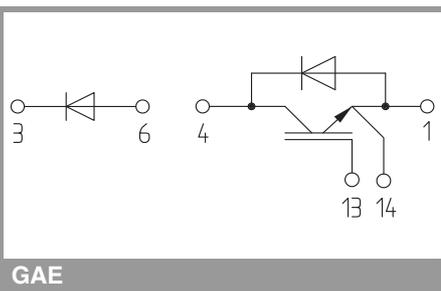


Fig. 12: Typ. CAL diode peak reverse recovery charge

Dimensions in mm



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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